

## P-Ch 30V Fast Switching MOSFETs



- ☒ Green Device Available
- ☒ Super Low Gate Charge
- ☒ Excellent CdV/dt effect decline
- ☒ Advanced high cell density Trench technology

### Product Summary

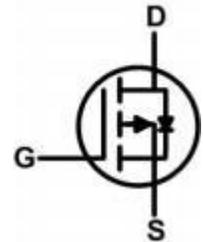
| BVDSS | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-------|---------------------|----------------|
| -30V  | 41mΩ                | -4.5A          |

### Description

The CP3401AL is the high cell density trenched P-ch MOSFETs, which provides excellent R<sub>DS(on)</sub> and efficiency for most of the small power switching and load switch applications.

The CP3401AL meet the RoHS and Green Product requirement with full function reliability approved.

### SOT23-3L Pin Configuration



### Absolute Maximum Ratings

| Symbol                 | Parameter                            | Rating     | Units |
|------------------------|--------------------------------------|------------|-------|
| V <sub>DS</sub>        | Drain-Source Voltage                 | -30        | V     |
| V <sub>GS</sub>        | Gate-Source Voltage                  | ±12        | V     |
| I <sub>D@TA=25°C</sub> | Continuous Drain Current             | -4.5       | A     |
| I <sub>D@TA=70°C</sub> | Continuous Drain Current             | -3.6       | A     |
| I <sub>DM</sub>        | Pulsed Drain Current <sup>2</sup>    | -16        | A     |
| P <sub>D@TA=25°C</sub> | Total Power Dissipation <sup>3</sup> | 1.4        | W     |
| P <sub>D@TA=70°C</sub> | Total Power Dissipation <sup>3</sup> | 0.9        | W     |
| T <sub>STG</sub>       | Storage Temperature Range            | -55 to 150 | °C    |
| T <sub>J</sub>         | Operating Junction Temperature Range | -55 to 150 | °C    |

### Thermal Data

| Symbol           | Parameter  | Typ. | Max. | Unit |
|------------------|--|------|------|------|
| R <sub>θJA</sub> | Thermal Resistance Junction-Ambient <sup>1</sup>           | ---  | 105  | °C/W |
| R <sub>θJA</sub> | Thermal Resistance Junction-Ambient <sup>1</sup> (t ≤ 10s) | ---  | ---  | °C/W |

**P-Ch 30V Fast Switching MOSFETs**
**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Parameter                                    | Symbol                     | Test Conditions  | Min. | Typ. | Max. | Unit |
|--|----------------------------|--|------|------|------|------|
| <b>Static Characteristics</b>                |                            |  |      |      |      |      |
| Drain-Source Breakdown Voltage               | <b>V<sub>(BR)DSS</sub></b> | V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA  | -30  | -    | -    | V    |
| Zero Gate Voltage Drain Current              | <b>I<sub>DSS</sub></b>     | V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V   | -    | -    | -1   | μA   |
| Gate-Body Leakage Current                    | <b>I<sub>GSS</sub></b>     | V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±12V   | -    | -    | ±100 | nA   |
| Gate-Threshold Voltage                       | <b>V<sub>GS(th)</sub></b>  | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA                                      | -0.7 | -1   | -1.3 | V    |
| Drain-Source on-Resistance <sup>3</sup>      | <b>R<sub>DS(on)</sub></b>  | V <sub>GS</sub> = -10V, I <sub>D</sub> = -4.2A   | -    | 41   | 60   | mΩ   |
|  |                            | V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -4A  | -    | 51   | 75   |      |
|  |                            | V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -1A  | -    | 60   | 90   |      |
| <b>Dynamic Characteristics<sup>4</sup></b>   |                            |  |      |      |      |      |
| Input Capacitance                            | <b>C<sub>iss</sub></b>     | V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V,<br>f = 1MHz  | -    | 745  | -    | pF   |
| Output Capacitance                           | <b>C<sub>oss</sub></b>     |  | -    | 70   | -    |      |
| Reverse Transfer Capacitance                 | <b>C<sub>rss</sub></b>     |  | -    | 57   | -    |      |
| <b>Switching Characteristics<sup>4</sup></b> |                            |  |      |      |      |      |
| Total Gate Charge                            | <b>Q<sub>g</sub></b>       | V <sub>GS</sub> = -4.5V, V <sub>DS</sub> = -15V,<br>I <sub>D</sub> = -4.2A                       | -    | 8    | -    | nC   |
| Gate-Source Charge                           | <b>Q<sub>gs</sub></b>      |  | -    | 1.8  | -    |      |
| Gate-Drain Charge                            | <b>Q<sub>gd</sub></b>      |  | -    | 2.7  | -    |      |
| Turn-on Delay Time                           | <b>t<sub>d(on)</sub></b>   | V <sub>GS</sub> = -10V, V <sub>DD</sub> = -15V,<br>I <sub>D</sub> = -4.2A, R <sub>GEN</sub> = 6Ω | -    | 7    | -    | ns   |
| Rise Time                                    | <b>t<sub>r</sub></b>       |  | -    | 3    | -    |      |
| Turn-off Delay Time                          | <b>t<sub>d(off)</sub></b>  |  | -    | 30   | -    |      |
| Fall Time                                    | <b>t<sub>f</sub></b>       |  | -    | 12   | -    |      |
| <b>Drain-Source Diode Characteristics</b>    |                            |  |      |      |      |      |
| Diode Forward Voltage <sup>3</sup>           | <b>V<sub>SD</sub></b>      | I <sub>S</sub> = -4.2A, V <sub>GS</sub> = 0V   | -    | -    | -1.2 | V    |
| Continuous Source Current                    | <b>I<sub>S</sub></b>       |  | -    | -    | -4.2 | A    |

**Notes:**

1. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C
2. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
3. Pulse Test: Pulse width≤300μs, duty cycle≤2%.
4. This value is guaranteed by design hence it is not included in the production test.

### Typical Characteristics

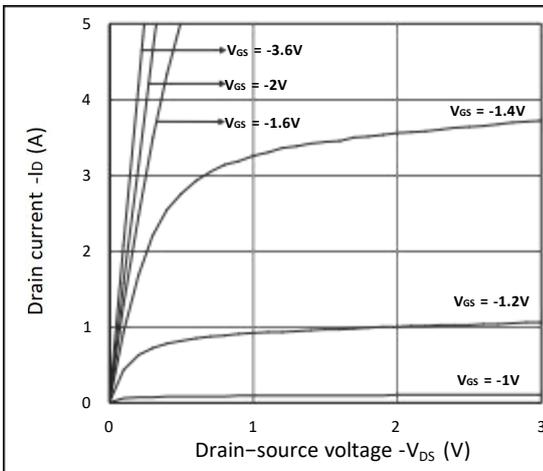


Figure 1. Output Characteristics

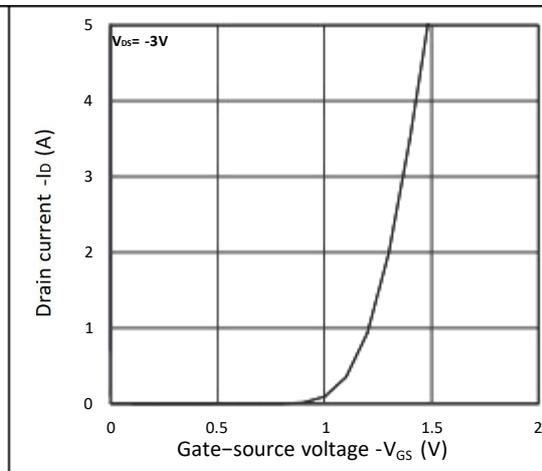


Figure 2. Transfer Characteristics

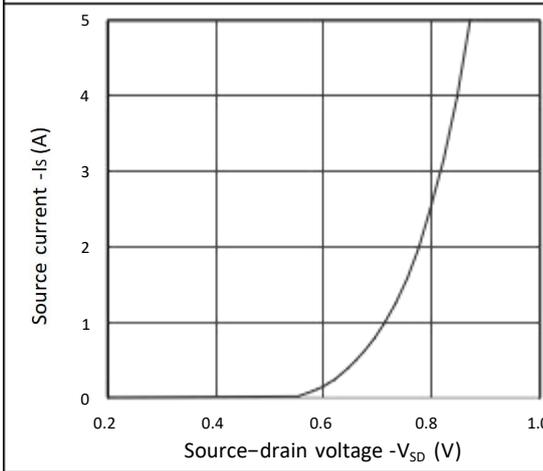


Figure 3. Forward Characteristics of Reverse

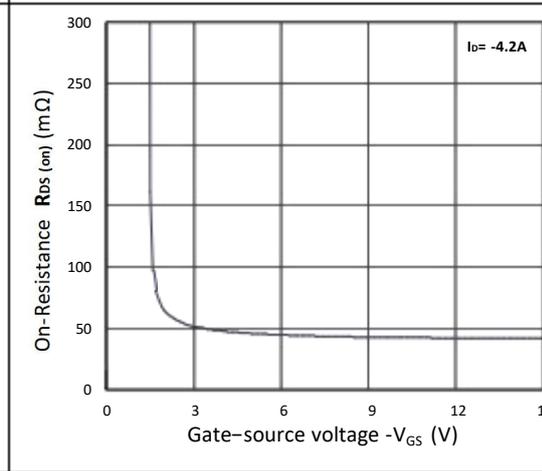


Figure 4.  $R_{DS(ON)}$  vs.  $V_{GS}$

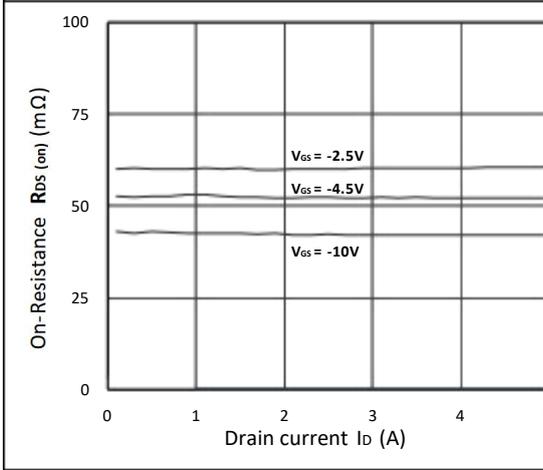


Figure 5.  $R_{DS(ON)}$  vs.  $I_D$

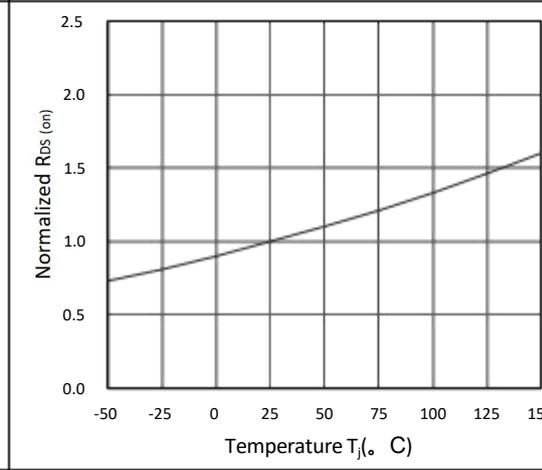


Figure 6. Normalized  $R_{DS(ON)}$  vs. Temperature

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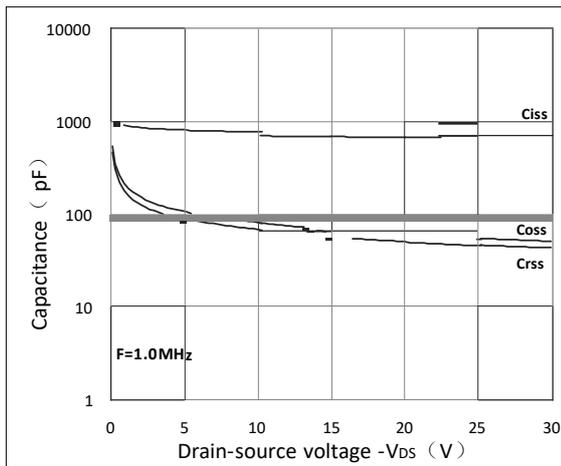


Figure 7. Capacitance Characteristics

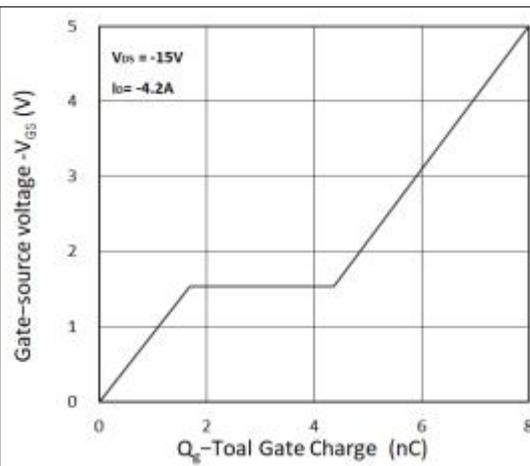


Figure 8. Gate Charge Characteristics

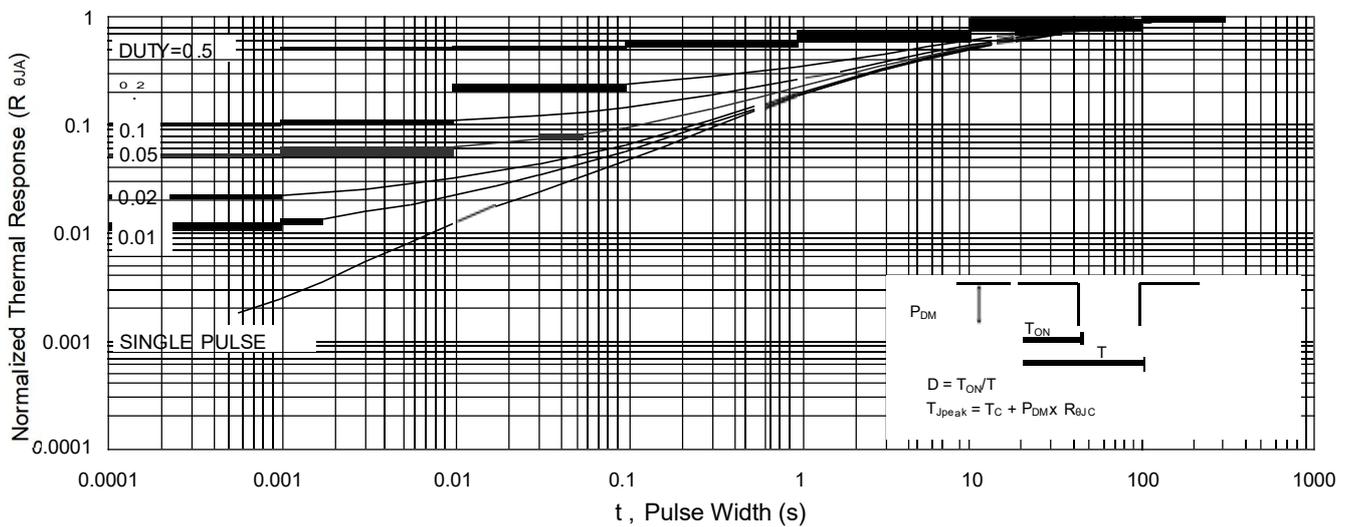


Fig.9 Normalized Maximum Transient Thermal Impedance

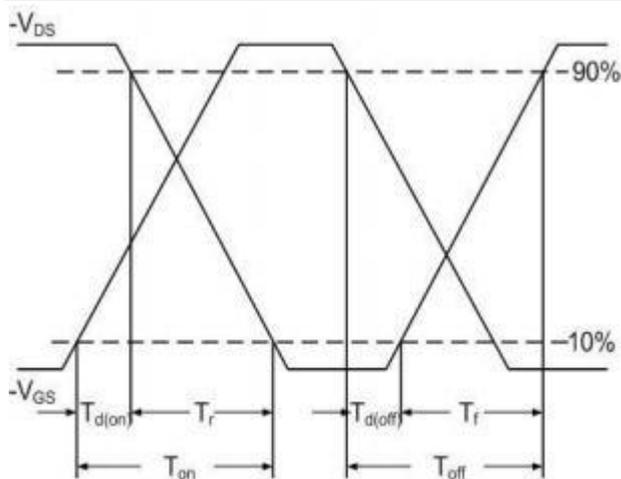


Fig.10 Switching Time Waveform

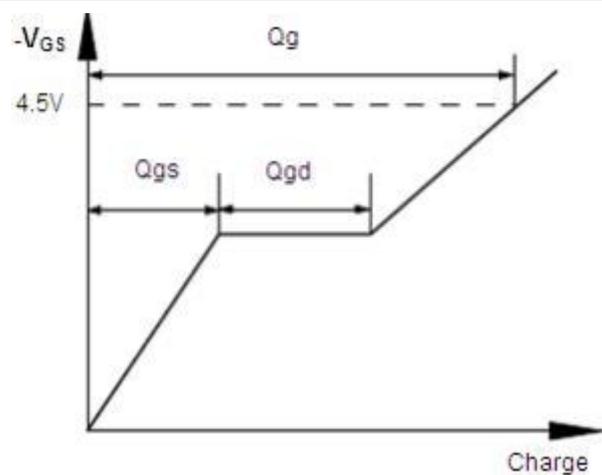
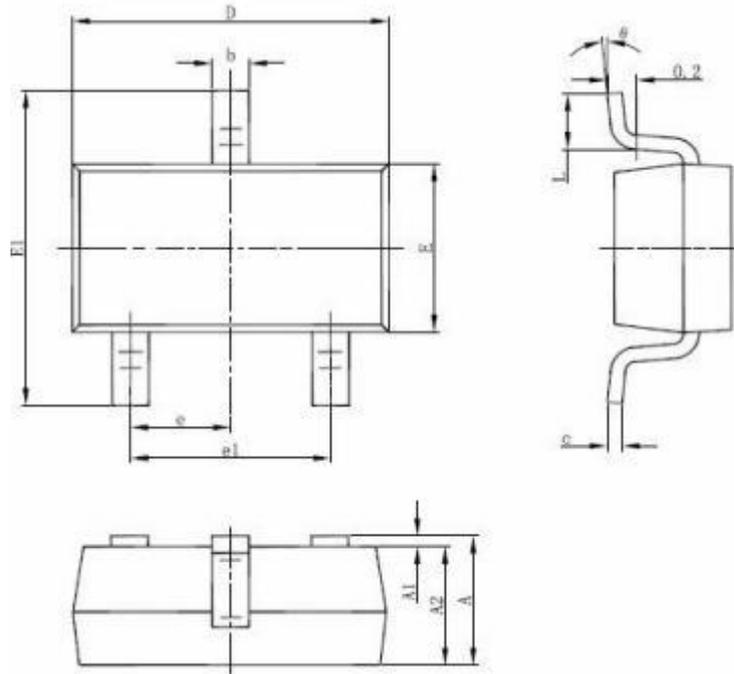


Fig.11 Gate Charge Waveform

Package Mechanical Data-SOT-23-3L



| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |
|--------|---------------------------|-------|----------------------|-------|
|        | Min                       | Max   | Min                  | Max   |
| A      | 1.050                     | 1.250 | 0.041                | 0.049 |
| A1     | 0.000                     | 0.100 | 0.000                | 0.004 |
| A2     | 1.050                     | 1.150 | 0.041                | 0.045 |
| b      | 0.300                     | 0.500 | 0.012                | 0.020 |
| c      | 0.100                     | 0.200 | 0.004                | 0.008 |
| D      | 2.820                     | 3.020 | 0.111                | 0.119 |
| E      | 1.500                     | 1.700 | 0.059                | 0.067 |
| E1     | 2.650                     | 2.950 | 0.104                | 0.116 |
| e      | 0.950(BSC)                |       | 0.037(BSC)           |       |
| e1     | 1.800                     | 2.000 | 0.071                | 0.079 |
| L      | 0.300                     | 0.600 | 0.012                | 0.024 |
| θ      | 0°                        | 8°    | 0°                   | 8°    |